Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/810,575	PARK, DAE-SUNG	
Examiner	Art Unit	

2832

Michael A. Friedhofer

SEARCHED					
Class	Subclass	Date	Examiner		
200	61.41- 61.44,61.7 -61.73	3/31/2005	MAF		
200	61.58r	3/31/2005	MAF		
200	61.62	3/31/2005	MAF		
335	205-207	3/31/2005	MAF		
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INTERFERENCE SEARCHED				
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